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Details

Product Status	Active
Core Processor	12V1
Core Size	16-Bit
Speed	25MHz
Connectivity	CANbus, IrDA, LINbus, SCI, SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	54
Program Memory Size	96КВ (96К × 8)
Program Memory Type	FLASH
EEPROM Size	3K x 8
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	3.13V ~ 5.5V
Data Converters	A/D 12x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/s9s12g96f0clh

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2.3.5 Pins PD7-0

Table 2-9. Port D Pins PD7-0

PD7-PD0 • These pins feature general-purpose I/O functionality only.

2.3.6 Pins PE1-0

Table 2-10. Port E Pins PE1-0

PE1	 If the CPMU OSC function is active this pin is used as XTAL signal and the pulldown device is disabled. 20 TSSOP: The SCI0 TXD signal is mapped to this pin when used with the SCI function. If the SCI0 TXD signal is enabled and routed here the I/O state will depend on the SCI0 configuration. 20 TSSOP: The TIM channel 3 signal is mapped to this pin when used with the timer function. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. 20 TSSOP: The PWM channel 1 signal is mapped to this pin when used with the PWM function. The enabled PWM channel forces the I/O state to be an output. 20 TSSOP: The ADC ETRIG1 signal is mapped to this pin when used with the ADC function. The enabled external trigger function has no effect on the I/O state. Refer to Section 2.6.4, "ADC External Triggers ETRIG3-0". Signal priority: 20 TSSOP: XTAL > TXD0 > IOC3 > PWM1 > GPO Others: XTAL > GPO
PE0	 If the CPMU OSC function is active this pin is used as EXTAL signal and the pulldown device is disabled. 20 TSSOP: The SCI0 RXD signal is mapped to this pin when used with the SCI function. If the SCI0 RXD signal is enabled and routed here the I/O state will be forced to input. 20 TSSOP: The TIM channel 2 signal is mapped to this pin when used with the timer function. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. 20 TSSOP: The PWM channel 0 signal is mapped to this pin when used with the PWM function. The enabled PWM channel forces the I/O state to be an output. 20 TSSOP: The ADC ETRIGO signal is mapped to this pin when used with the ADC function. The enabled external trigger function has no effect on the I/O state. Refer to Section 2.6.4, "ADC External Triggers ETRIG3-0". Signal priority: 20 TSSOP: EXTAL > RXD0 > IOC2 > PWM0 > GPO Others: EXTAL > GPO

2.3.7 Pins PT7-0

Table 2-11. Port T Pins PT7-0

PT7-PT6	 64/100 LQFP: The TIM channels 7 and 6 signal are mapped to these pins when used with the timer function. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. Signal priority: 64/100 LQFP: IOC7-6 > GPO
PT5	 48/64/100 LQFP: The TIM channel 5 signal is mapped to this pin when used with the timer function. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. If the ACMP timer link is enabled this pin is disconnected from the timer input so that it can still be used as general-purpose I/O or as timer output. The use case for the ACMP timer link requires the timer input capture function to be enabled. Signal priority: 48/64/100 LQFP: IOC5 > GPO

Field	Description
7–0 DP[15:8]	Direct Page Index Bits 15–8 — These bits are used by the CPU when performing accesses using the direct addressing mode. These register bits form bits [15:8] of the local address (see Figure 5-6).





Figure 5-6. DIRECT Address Mapping

Example 5-1. This example demonstrates usage of the Direct Addressing Mode

MOVB	#\$04,DIRECT	;Set DIRECT register to 0x04. From this point on, all memory ;accesses using direct addressing mode will be in the local
LDY	<\$12	;address range from 0x0400 to 0x04FF. ;Load the Y index register from 0x0412 (direct access).

5.3.2.3 MMC Control Register (MMCCTL1)



Read: Anytime.

Write: Anytime.

The NVMRES bit maps 16k of internal NVM resources (see Section FTMRG) to the global address space 0x04000 to 0x07FFF.

Table 5-6. MODE Field Descriptions

Field	Description			
0	Map internal NVM resources into the global memory map			
NVMRES	Write: Anytime			
	This bit maps internal NVM resources into the global address space.			
	0 Program flash is mapped to the global address range from 0x04000 to 0x07FFF.			
	1 NVM resources are mapped to the global address range from 0x04000 to 0x07FFF.			

SC[3:0]	Description (Unspecified matches have no effect)				
0001	Match2 to State2 Match1 to Final State				
0010	Match0 to Final State Match1 to State1				
0011	Match1 to Final State Match2 to State1				
0100	Match1 to State2				
0101	Match1 to Final State				
0110	Match2 to State2 Match0 to Final State				
0111	Match0 to Final State				
1000	Reserved				
1001	Reserved				
1010	Either Match1 or Match2 to State1 Match0 to Final State				
1011	Reserved				
1100	Reserved				
1101	Either Match1 or Match2 to Final State Match0 to State1				
1110	Match0 to State2 Match2 to Final State				
1111	Reserved				

Table 8-20. State3 — Sequencer Next State Selection

The priorities described in Table 8-36 dictate that in the case of simultaneous matches, a match leading to final state has priority followed by the match on the lower channel number (0,1,2).

8.3.2.7.4 Debug Match Flag Register (DBGMFR)



Read: If COMRV[1:0] = 11

Write: Never

DBGMFR is visible at 0x0027 only with COMRV[1:0] = 11. It features 3 flag bits each mapped directly to a channel. Should a match occur on the channel during the debug session, then the corresponding flag is set and remains set until the next time the module is armed by writing to the ARM bit. Thus the contents are retained after a debug session for evaluation purposes. These flags cannot be cleared by software, they are cleared only when arming the module. A set flag does not inhibit the setting of other flags. Once a flag is set, further comparator matches on the same channel in the same session have no affect on that flag.

8.3.2.8 Comparator Register Descriptions

Each comparator has a bank of registers that are visible through an 8-byte window in the DBG module register address map. Comparator A consists of 8 register bytes (3 address bus compare registers, two data bus compare registers, two data bus mask registers and a control register). Comparator B consists of four

S12 Clock, Reset and Power Management Unit (S12CPMU)

Addres s	Name		Bit 7	6	5	4	3	2	1	Bit 0
0x003B	CPMURTI	R W	RTDEC	RTR6	RTR5	RTR4	RTR3	RTR2	RTR1	RTR0
0x003C	CPMUCOP	R W	WCOP	RSBCK	0 WRTMASK	0	0	CR2	CR1	CR0
020030	RESERVEDCP	R	0	0	0	0	0	0	0	0
0x003D	MUTEST0	W								
0x003E	RESERVEDCP	R	0	0	0	0	0	0	0	0
UXUUSL	MUTEST1	W								
0x003E	CPMU	R	0	0	0	0	0	0	0	0
execci	ARMCOP	W	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
0x02F0	RESERVED	R W	0	0	0	0	0	0	0	0
0.000001	CPMU	R	0	0	0	0	0	LVDS		
	LVCTL	W								LVIF
0x02F2	CPMU APICTL	R W	APICLK	0	0	APIES	APIEA	APIFE	APIE	APIF
0x02F3	CPMUACLKTR	R W	ACLKTR5	ACLKTR4	ACLKTR3	ACLKTR2	ACLKTR1	ACLKTR0	0	0
0x02F4	CPMUAPIRH	R W	APIR15	APIR14	APIR13	APIR12	APIR11	APIR10	APIR9	APIR8
0x02F5	CPMUAPIRL	R W	APIR7	APIR6	APIR5	APIR4	APIR3	APIR2	APIR1	APIR0
0x02F6	RESERVEDCP	R	0	0	0	0	0	0	0	0
0/1021 0	MUTEST3	W								
0x02F7	RESERVED	R	0	0	0	0	0	0	0	0
		W								
0x02F8	CPMU IRCTRIMH	R W		TCTRIM[4:0] 0 IRCTRIM[9:8]			M[9:8]			
0x02F9	CPMU IRCTRIML	R W		IRCTRIM[7:0]						
0x02FA	CPMUOSC	R W	OSCE	Reserved	OSCPINS_ EN	IS Reserved				
0x02FB	CPMUPROT	R W	0	0	0	0	0	0	0	PROT
0,00000	RESERVEDCP	R	0	0	0	0	0	0	0	0
UXU2FC	MUTEST2	W								

= Unimplemented or Reserved

Figure 10-3. CPMU Register Summary

18.1.1 Glossary

	-	
ACK	Acknowledge of CAN message	
CAN	Controller Area Network	
CRC	Cyclic Redundancy Code	
EOF	End of Frame	
FIFO	First-In-First-Out Memory	
IFS	Inter-Frame Sequence	
SOF	Start of Frame	
CPU bus	CPU related read/write data bus	
CAN bus	CAN protocol related serial bus	
oscillator clock	Direct clock from external oscillator	
bus clock	CPU bus related clock	
CAN clock	CAN protocol related clock	

Table 18-2. Terminology

18.1.2 Block Diagram



Figure 18-1. MSCAN Block Diagram

message in its RxBG (wrong identifier, transmission errors, etc.) the actual contents of the buffer will be over-written by the next message. The buffer will then not be shifted into the FIFO.

When the MSCAN module is transmitting, the MSCAN receives its own transmitted messages into the background receive buffer, RxBG, but does not shift it into the receiver FIFO, generate a receive interrupt, or acknowledge its own messages on the CAN bus. The exception to this rule is in loopback mode (see Section 18.3.2.2, "MSCAN Control Register 1 (CANCTL1)") where the MSCAN treats its own messages exactly like all other incoming messages. The MSCAN receives its own transmitted messages in the event that it loses arbitration. If arbitration is lost, the MSCAN must be prepared to become a receiver.

An overrun condition occurs when all receive message buffers in the FIFO are filled with correctly received messages with accepted identifiers and another message is correctly received from the CAN bus with an accepted identifier. The latter message is discarded and an error interrupt with overrun indication is generated if enabled (see Section 18.4.7.5, "Error Interrupt"). The MSCAN remains able to transmit messages while the receiver FIFO is being filled, but all incoming messages are discarded. As soon as a receive buffer in the FIFO is available again, new valid messages will be accepted.

18.4.3 Identifier Acceptance Filter

The MSCAN identifier acceptance registers (see Section 18.3.2.12, "MSCAN Identifier Acceptance Control Register (CANIDAC)") define the acceptable patterns of the standard or extended identifier (ID[10:0] or ID[28:0]). Any of these bits can be marked 'don't care' in the MSCAN identifier mask registers (see Section 18.3.2.18, "MSCAN Identifier Mask Registers (CANIDMR0–CANIDMR7)").

A filter hit is indicated to the application software by a set receive buffer full flag (RXF = 1) and three bits in the CANIDAC register (see Section 18.3.2.12, "MSCAN Identifier Acceptance Control Register (CANIDAC)"). These identifier hit flags (IDHIT[2:0]) clearly identify the filter section that caused the acceptance. They simplify the application software's task to identify the cause of the receiver interrupt. If more than one hit occurs (two or more filters match), the lower hit has priority.

A very flexible programmable generic identifier acceptance filter has been introduced to reduce the CPU interrupt loading. The filter is programmable to operate in four different modes:

- Two identifier acceptance filters, each to be applied to:
 - The full 29 bits of the extended identifier and to the following bits of the CAN 2.0B frame:
 - Remote transmission request (RTR)
 - Identifier extension (IDE)
 - Substitute remote request (SRR)
 - The 11 bits of the standard identifier plus the RTR and IDE bits of the CAN 2.0A/B messages. This mode implements two filters for a full length CAN 2.0B compliant extended identifier. Although this mode can be used for standard identifiers, it is recommended to use the four or eight identifier acceptance filters.

Figure 18-40 shows how the first 32-bit filter bank (CANIDAR0–CANIDAR3, CANIDMR0–CANIDMR3) produces a filter 0 hit. Similarly, the second filter bank (CANIDAR4–CANIDAR7, CANIDMR4–CANIDMR7) produces a filter 1 hit.

• Four identifier acceptance filters, each to be applied to:

22.3.2.3 Timer Count Register (TCNT)

Module Base + 0x0004



Figure 22-7. Timer Count Register Low (TCNTL)

The 16-bit main timer is an up counter.

A full access for the counter register should take place in one clock cycle. A separate read/write for high byte and low byte will give a different result than accessing them as a word.

Read: Anytime

Module Base + 0x0006

Write: Has no meaning or effect in the normal mode; only writable in special modes (test_mode = 1).

The period of the first count after a write to the TCNT registers may be a different size because the write is not synchronized with the prescaler clock.

22.3.2.4 Timer System Control Register 1 (TSCR1)



Figure 22-8. Timer System Control Register 1 (TSCR1)

Read: Anytime

Write: Anytime

Any access to TCNT will clear TFLG2 register if the TFFCA bit in TSCR register is set.

Table 23-17. TRLG2 Field Descriptions

Field	Description
7 TOF	Timer Overflow Flag — Set when 16-bit free-running timer overflows from 0xFFFF to 0x0000. Clearing this bit requires writing a one to bit 7 of TFLG2 register while the TEN bit of TSCR1 or PAEN bit of PACTL is set to one (See also TCRE control bit explanation).

23.3.2.14 Timer Input Capture/Output Compare Registers High and Low 0– 7(TCxH and TCxL)



Figure 23-23. Timer Input Capture/Output Compare Register x Low (TCxL)

¹ This register is available only when the corresponding channel exists and is reserved if that channel does not exist. Writes to a reserved register have no functional effect. Reads from a reserved register return zeroes.

Depending on the TIOS bit for the corresponding channel, these registers are used to latch the value of the free-running counter when a defined transition is sensed by the corresponding input capture edge detector or to trigger an output action for output compare.

Read: Anytime

Write: Anytime for output compare function.Writes to these registers have no meaning or effect during input capture. All timer input capture/output compare registers are reset to 0x0000.

NOTE

Read/Write access in byte mode for high byte should take place before low byte otherwise it will give a different result.

8. Reset the MCU

24.5.3 Mode and Security Effects on Flash Command Availability

The availability of Flash module commands depends on the MCU operating mode and security state as shown in Table 24-25.

24.6 Initialization

On each system reset the flash module executes an initialization sequence which establishes initial values for the Flash Block Configuration Parameters, the FPROT and EEPROT protection registers, and the FOPT and FSEC registers. The initialization routine reverts to built-in default values that leave the module in a fully protected and secured state if errors are encountered during execution of the reset sequence. If a double bit fault is detected during the reset sequence, both MGSTAT bits in the FSTAT register will be set.

CCIF is cleared throughout the initialization sequence. The Flash module holds off all CPU access for a portion of the initialization sequence. Flash reads are allowed once the hold is removed. Completion of the initialization sequence is marked by setting CCIF high which enables user commands.

If a reset occurs while any Flash command is in progress, that command will be immediately aborted. The state of the word being programmed or the sector/block being erased is not guaranteed.

32 KByte Flash Module (S12FTMRG32K1V1)

The user code stored in the P-Flash memory must have a method of receiving the backdoor keys from an external stimulus. This external stimulus would typically be through one of the on-chip serial ports.

If the KEYEN[1:0] bits are in the enabled state (see Section 25.3.2.2), the MCU can be unsecured by the backdoor key access sequence described below:

- 1. Follow the command sequence for the Verify Backdoor Access Key command as explained in Section 25.4.6.11
- 2. If the Verify Backdoor Access Key command is successful, the MCU is unsecured and the SEC[1:0] bits in the FSEC register are forced to the unsecure state of 10

The Verify Backdoor Access Key command is monitored by the Memory Controller and an illegal key will prohibit future use of the Verify Backdoor Access Key command. A reset of the MCU is the only method to re-enable the Verify Backdoor Access Key command. The security as defined in the Flash security byte (0x3_FF0F) is not changed by using the Verify Backdoor Access Key command sequence. The backdoor keys stored in addresses 0x3_FF00-0x3_FF07 are unaffected by the Verify Backdoor Access Key command sequence. The Verify Backdoor Access Key command sequence has no effect on the program and erase protections defined in the Flash protection register, FPROT.

After the backdoor keys have been correctly matched, the MCU will be unsecured. After the MCU is unsecured, the sector containing the Flash security byte can be erased and the Flash security byte can be reprogrammed to the unsecure state, if desired. In the unsecure state, the user has full control of the contents of the backdoor keys by programming addresses 0x3_FF00-0x3_FF07 in the Flash configuration field.

25.5.2 Unsecuring the MCU in Special Single Chip Mode using BDM

A secured MCU can be unsecured in special single chip mode by using the following method to erase the P-Flash and EEPROM memory:

- 1. Reset the MCU into special single chip mode
- 2. Delay while the BDM executes the Erase Verify All Blocks command write sequence to check if the P-Flash and EEPROM memories are erased
- 3. Send BDM commands to disable protection in the P-Flash and EEPROM memory
- 4. Execute the Erase All Blocks command write sequence to erase the P-Flash and EEPROM memory. Alternatively the Unsecure Flash command can be executed, if so the steps 5 and 6 below are skeeped.
- 5. After the CCIF flag sets to indicate that the Erase All Blocks operation has completed, reset the MCU into special single chip mode
- 6. Delay while the BDM executes the Erase Verify All Blocks command write sequence to verify that the P-Flash and EEPROM memory are erased

If the P-Flash and EEPROM memory are verified as erased, the MCU will be unsecured. All BDM commands will now be enabled and the Flash security byte may be programmed to the unsecure state by continuing with the following steps:

7. Send BDM commands to execute the Program P-Flash command write sequence to program the Flash security byte to the unsecured state

26.4.6.2 Erase Verify Block Command

The Erase Verify Block command allows the user to verify that an entire P-Flash or EEPROM block has been erased. The FCCOB FlashBlockSelectionCode[1:0] bits determine which block must be verified.

Table 26-33. Era	se Verify Block	Command FCCOB	Requirements
------------------	-----------------	---------------	--------------

CCOBIX[2:0]	FCCOB Parameters		
000	0x02	Flash block selection code [1:0]. See Table 26-34	

Table 26-34. Flash block selection code description

Selection code[1:0]	Flash block to be verified
00	EEPROM
01	Invalid (ACCERR)
10	Invalid (ACCERR)
11	P-Flash

Upon clearing CCIF to launch the Erase Verify Block command, the Memory Controller will verify that the selected P-Flash or EEPROM block is erased. The CCIF flag will set after the Erase Verify Block operation has completed. If the block is not erased, it means blank check failed, both MGSTAT bits will be set.

 Table 26-35. Erase Verify Block Command Error Handling

Register	Error Bit	Error Condition
	ACCERR	Set if CCOBIX[2:0] != 000 at command launch
		Set if an invalid FlashBlockSelectionCode[1:0] is supplied
FSTAT	FPVIOL	None
MGSTAT1	Set if any errors have been encountered during the read or if blank check failed.	
	MGSTAT0	Set if any non-correctable errors have been encountered during the read or if blank check failed.

26.4.6.3 Erase Verify P-Flash Section Command

The Erase Verify P-Flash Section command will verify that a section of code in the P-Flash memory is erased. The Erase Verify P-Flash Section command defines the starting point of the code to be verified and the number of phrases.

Register	Error Bit	Error Condition
	Set if CCOBIX[2:0] != 010 at command launch	
	Set if command not available in current mode (see Table 26-27)	
	ACCERR	Set if an invalid global address [17:0] is supplied
		Set if a misaligned word address is supplied (global address [0] != 0)
FSTAT	FSTAT	Set if the requested section breaches the end of the EEPROM block
	FPVIOL	None
	MGSTAT1	Set if any errors have been encountered during the read or if blank check failed.
MGSTAT0	Set if any non-correctable errors have been encountered during the read or if blank check failed.	

Table 26-61. Erase Verify EEPROM Section Command Error Handling

26.4.6.15 Program EEPROM Command

The Program EEPROM operation programs one to four previously erased words in the EEPROM block. The Program EEPROM operation will confirm that the targeted location(s) were successfully programmed upon completion.

CAUTION

A Flash word must be in the erased state before being programmed. Cumulative programming of bits within a Flash word is not allowed.

 Table 26-62. Program EEPROM Command FCCOB Requirements

CCOBIX[2:0]	FCCOB P	arameters
000	0x11	Global address [17:16] to identify the EEPROM block
001	Global address [15:0] of word to be programmed	
010	Word 0 program value	
011	Word 1 program value, if desired	
100	Word 2 program value, if desired	
101	Word 3 program value, if desired	

Upon clearing CCIF to launch the Program EEPROM command, the user-supplied words will be transferred to the Memory Controller and be programmed if the area is unprotected. The CCOBIX index value at Program EEPROM command launch determines how many words will be programmed in the EEPROM block. The CCIF flag is set when the operation has completed.

26.4.7 Interrupts

The Flash module can generate an interrupt when a Flash command operation has completed or when a Flash command operation has detected an ECC fault.

Interrupt Source	Interrupt Flag	Local Enable	Global (CCR) Mask
Flash Command Complete	CCIF (FSTAT register)	CCIE (FCNFG register)	l Bit
ECC Double Bit Fault on Flash Read	DFDIF (FERSTAT register)	DFDIE (FERCNFG register)	l Bit
ECC Single Bit Fault on Flash Read	SFDIF (FERSTAT register)	SFDIE (FERCNFG register)	l Bit

Table	26-66.	Flash	Interrupt	Sources
-------	--------	-------	-----------	---------

NOTE

Vector addresses and their relative interrupt priority are determined at the MCU level.

26.4.7.1 Description of Flash Interrupt Operation

The Flash module uses the CCIF flag in combination with the CCIE interrupt enable bit to generate the Flash command interrupt request. The Flash module uses the DFDIF and SFDIF flags in combination with the DFDIE and SFDIE interrupt enable bits to generate the Flash error interrupt request. For a detailed description of the register bits involved, refer to Section 26.3.2.5, "Flash Configuration Register (FCNFG)", Section 26.3.2.6, "Flash Error Configuration Register (FERCNFG)", Section 26.3.2.7, "Flash Status Register (FSTAT)", and Section 26.3.2.8, "Flash Error Status Register (FERSTAT)".

The logic used for generating the Flash module interrupts is shown in Figure 26-27.



Figure 26-27. Flash Module Interrupts Implementation

96 KByte Flash Module (S12FTMRG96K1V1)

28.3.2.5 Flash Configuration Register (FCNFG)

The FCNFG register enables the Flash command complete interrupt and forces ECC faults on Flash array read access from the CPU.



Figure 28-9. Flash Configuration Register (FCNFG)

CCIE, IGNSF, FDFD, and FSFD bits are readable and writable while remaining bits read 0 and are not writable.

Field	Description
7 CCIE	 Command Complete Interrupt Enable — The CCIE bit controls interrupt generation when a Flash command has completed. 0 Command complete interrupt disabled 1 An interrupt will be requested whenever the CCIF flag in the FSTAT register is set (see Section 28.3.2.7)
4 IGNSF	 Ignore Single Bit Fault — The IGNSF controls single bit fault reporting in the FERSTAT register (see Section 28.3.2.8). 0 All single bit faults detected during array reads are reported 1 Single bit faults detected during array reads are not reported and the single bit fault interrupt will not be generated
1 FDFD	 Force Double Bit Fault Detect — The FDFD bit allows the user to simulate a double bit fault during Flash array read operations and check the associated interrupt routine. The FDFD bit is cleared by writing a 0 to FDFD. 0 Flash array read operations will set the DFDIF flag in the FERSTAT register only if a double bit fault is detected 1 Any Flash array read operation will force the DFDIF flag in the FERSTAT register to be set (see Section 28.3.2.7) and an interrupt will be generated as long as the DFDIE interrupt enable in the FERCNFG register is set (see Section 28.3.2.6)
0 FSFD	 Force Single Bit Fault Detect — The FSFD bit allows the user to simulate a single bit fault during Flash array read operations and check the associated interrupt routine. The FSFD bit is cleared by writing a 0 to FSFD. 0 Flash array read operations will set the SFDIF flag in the FERSTAT register only if a single bit fault is detected 1 Flash array read operation will force the SFDIF flag in the FERSTAT register to be set (see Section 28.3.2.7) and an interrupt will be generated as long as the SFDIE interrupt enable in the FERCNFG register is set (see Section 28.3.2.6)

Table 28-13. FCNFG Field Descriptions

28.3.2.6 Flash Error Configuration Register (FERCNFG)

The FERCNFG register enables the Flash error interrupts for the FERSTAT flags.

29.4.6.2 Erase Verify Block Command

The Erase Verify Block command allows the user to verify that an entire P-Flash or EEPROM block has been erased. The FCCOB FlashBlockSelectionCode[1:0] bits determine which block must be verified.

Fable 29-33. Erase Verif	y Block Command	FCCOB Requirements
--------------------------	-----------------	---------------------------

CCOBIX[2:0]	FCCOB Parameters	
000	0x02	Flash block selection code [1:0]. See Table 29-34

Table 29-34. Flash block selection code description

Selection code[1:0]	Flash block to be verified
00	EEPROM
01	Invalid (ACCERR)
10	P-Flash
11	P-Flash

Upon clearing CCIF to launch the Erase Verify Block command, the Memory Controller will verify that the selected P-Flash or EEPROM block is erased. The CCIF flag will set after the Erase Verify Block operation has completed. If the block is not erased, it means blank check failed, both MGSTAT bits will be set.

Table 29-35. Erase Verify	Block Command Erro	or Handling
---------------------------	--------------------	-------------

Register	Error Bit	Error Condition
	ACCERR	Set if CCOBIX[2:0] != 000 at command launch
	ACCENT	Set if an invalid FlashBlockSelectionCode[1:0] is supplied
FSTAT	FPVIOL	None
MGSTAT1	Set if any errors have been encountered during the read or if blank check failed.	
	MGSTAT0	Set if any non-correctable errors have been encountered during the read or if blank check failed.

29.4.6.3 Erase Verify P-Flash Section Command

The Erase Verify P-Flash Section command will verify that a section of code in the P-Flash memory is erased. The Erase Verify P-Flash Section command defines the starting point of the code to be verified and the number of phrases.

31.4.6.15 Program EEPROM Command

The Program EEPROM operation programs one to four previously erased words in the EEPROM block. The Program EEPROM operation will confirm that the targeted location(s) were successfully programmed upon completion.

CAUTION

A Flash word must be in the erased state before being programmed. Cumulative programming of bits within a Flash word is not allowed.

CCOBIX[2:0]	FCCOB Parameters				
000	0x11	Global address [17:16] to identify the EEPROM block			
001	Global address [15:0] of word to be programmed				
010	Word 0 program value				
011	Word 1 program value, if desired				
100	Word 2 program value, if desired				
101	Word 3 program value, if desired				

 Table 31-62. Program EEPROM Command FCCOB Requirements

Upon clearing CCIF to launch the Program EEPROM command, the user-supplied words will be transferred to the Memory Controller and be programmed if the area is unprotected. The CCOBIX index value at Program EEPROM command launch determines how many words will be programmed in the EEPROM block. The CCIF flag is set when the operation has completed.

Table 31-63. Progra	am EEPROM Commar	nd Error Handling
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Register	Error Bit	Error Condition			
		Set if CCOBIX[2:0] < 010 at command launch			
	ACCERR	Set if CCOBIX[2:0] > 101 at command launch			
		Set if command not available in current mode (see Table 31-27)			
		Set if an invalid global address [17:0] is supplied			
FSTAT		Set if a misaligned word address is supplied (global address [0] != 0)			
		Set if the requested group of words breaches the end of the EEPROM block			
	FPVIOL	Set if the selected area of the EEPROM memory is protected			
	MGSTAT1	Set if any errors have been encountered during the verify operation			
	MGSTAT0	Set if any non-correctable errors have been encountered during the verify operation			

31.4.6.16 Erase EEPROM Sector Command

The Erase EEPROM Sector operation will erase all addresses in a sector of the EEPROM block.

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reprogrammed to the unsecure state, if desired. In the unsecure state, the user has full control of the contents of the backdoor keys by programming addresses 0x3_FF00-0x3_FF07 in the Flash configuration field.

31.5.2 Unsecuring the MCU in Special Single Chip Mode using BDM

A secured MCU can be unsecured in special single chip mode by using the following method to erase the P-Flash and EEPROM memory:

- 1. Reset the MCU into special single chip mode
- 2. Delay while the BDM executes the Erase Verify All Blocks command write sequence to check if the P-Flash and EEPROM memories are erased
- 3. Send BDM commands to disable protection in the P-Flash and EEPROM memory
- 4. Execute the Erase All Blocks command write sequence to erase the P-Flash and EEPROM memory. Alternatively the Unsecure Flash command can be executed, if so the steps 5 and 6 below are skeeped.
- 5. After the CCIF flag sets to indicate that the Erase All Blocks operation has completed, reset the MCU into special single chip mode
- 6. Delay while the BDM executes the Erase Verify All Blocks command write sequence to verify that the P-Flash and EEPROM memory are erased

If the P-Flash and EEPROM memory are verified as erased, the MCU will be unsecured. All BDM commands will now be enabled and the Flash security byte may be programmed to the unsecure state by continuing with the following steps:

- 7. Send BDM commands to execute the Program P-Flash command write sequence to program the Flash security byte to the unsecured state
- 8. Reset the MCU

31.5.3 Mode and Security Effects on Flash Command Availability

The availability of Flash module commands depends on the MCU operating mode and security state as shown in Table 31-27.

31.6 Initialization

On each system reset the flash module executes an initialization sequence which establishes initial values for the Flash Block Configuration Parameters, the FPROT and EEPROT protection registers, and the FOPT and FSEC registers. The initialization routine reverts to built-in default values that leave the module in a fully protected and secured state if errors are encountered during execution of the reset sequence. If a double bit fault is detected during the reset sequence, both MGSTAT bits in the FSTAT register will be set.

CCIF is cleared throughout the initialization sequence. The Flash module holds off all CPU access for a portion of the initialization sequence. Flash reads are allowed once the hold is removed. Completion of the initialization sequence is marked by setting CCIF high which enables user commands.

Electrical Characteristics

Condit	Conditions are: Typ: V _{DDX} ,V _{DDR} ,V _{DDA} =5V, Max: V _{DDX} ,V _{DDR} ,V _{DDA} =5.5V API see Table A-13.							
Num	С	Rating	Symbol	Min	Тур	Max	Unit	
S12GN	V16, S	512GN32						
		Stop Current API	disabled					
1	Р	-40°C	I _{DDS}		14.4	24	μΑ	
2	Р	25°C	I _{DDS}		16.5	28	μΑ	
3	Ρ	150°C	I _{DDS}		120	320	μΑ	
4	С	160°C	I _{DDS}		140		μA	
Stop Current API enabled								
5	С	-40°C	I _{DDS}		18.5		μA	
6	С	25°C	I _{DDS}		21.5		μA	
7	С	150°C	I _{DDS}		130		μA	
8	С	160°C	I _{DDS}		150		μA	
S12GN	V48, S	S12G48, S12G64						
	-	Stop Current API	disabled				_	
9	Р	-40°C	I _{DDS}		16	27	μA	
10	Р	25°C	I _{DDS}		18.5	30	μA	
11	Ρ	150°C	I _{DDS}		140	370	μA	
	-	Stop Current API	enabled				_	
12	С	-40°C	I _{DDS}		20		μA	
13	С	25°C	I _{DDS}		23.5		μA	
14	С	150°C	I _{DDS}		150		μA	
S12G9	S12G96, S12G128							
	-	Stop Current API	disabled					
15	Р	-40°C	I _{DDS}		16.5	28	μA	
16	Р	25°C	I _{DDS}		19	32	μA	
17	Ρ	150°C	I _{DDS}		150	400	μA	
	-	Stop Current API	enabled					
18	С	-40°C	I _{DDS}		20.5		μA	
19	С	25°C	I _{DDS}		24		μA	
20	С	150°C	I _{DDS}		160		μA	
S12G1	192, 8	512GA192, S12G240, S12GA240						
		Stop Current API	disabled					
21	Р	-40°C	I _{DDS}		17	30	μA	
22	Р	25°C	I _{DDS}		19.5	34	μA	
23	Р	150°C	I _{DDS}		155	420	μA	
	Stop Current API enabled							
24	С	-40°C	I _{DDS}		21		μA	
25	С	25°C	I _{DDS}		24.5		μA	
26	С	150°C	I _{DDS}		160		μA	

Table A-17. Full Stop Current Characteristics

A.10 Electrical Characteristics for the Oscillator (XOSCLCP)

Table A-44. XOSCLCP Characteristics (Junction Temperature From –40°C To +150°C)

Conditions are shown in Table A-4 unless otherwise noted							
Num	С	Rating	Symbol	Min	Тур	Max	Unit
1	С	Nominal crystal or resonator frequency	f _{OSC}	4.0		16	MHz
2	Ρ	Startup Current	iosc	100			μA
3a	С	Oscillator start-up time (4MHz) ¹	t _{UPOSC}		2	10	ms
3b	С	Oscillator start-up time (8MHz) ¹	t _{UPOSC}	_	1.6	8	ms
3c	С	Oscillator start-up time (16MHz) ¹	t _{UPOSC}	—	1	5	ms
4	Ρ	Clock Monitor Failure Assert Frequency	f _{CMFA}	200	450	1200	KHz
5	D	Input Capacitance (EXTAL, XTAL pins)	C _{IN}		7		pF
6	С	EXTAL Pin Input Hysteresis	V _{HYS,EXTA} L	_	120		mV
7	с	EXTAL Pin oscillation amplitude (loop controlled Pierce) all mask sets except for 2N75C and 2N55V	V _{PP,EXTAL}		1.0		V
8	D	EXTAL Pin oscillation required amplitude ² (loop controlled Pierce) all mask sets except for 2N75C and 2N55V	V _{PP,EXTAL}	0.8	_	1.5	V

¹ These values apply for carefully designed PCB layouts with capacitors that match the crystal/resonator requirements.

² Needs to be measured at room temperature on the application board using a probe with very low (<=5pF) input capacitance.